

Notice of References Cited

Application/Control No.

10/574,365

Applicant(s)/Patent Under
Reexamination
PHAN LE, KIM

Examiner

ALEXANDER G. SOFOCLEOUS

Art Unit

2824

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,914,805	07-2005	Witcraft et al.	365/158
*	B	US-6,873,055	03-2005	Bangert, Joachim	257/775
	C	US-			
	D	US-			
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	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	WO 02/41367 Jones et al. "Self-Aligned Magnetic Clad Write Line and Method Thereof." published May 22, 2002
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.